

Product Summary

$V_{(BR)DSS}$	$R_{DS(on)TYP}$	I_D
40V	4.5mΩ@10V	75A
	6.5mΩ@4.5V	

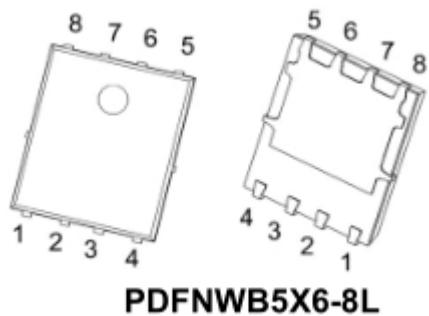
Feature

- Low On-Resistance
- Low Input Capacitance

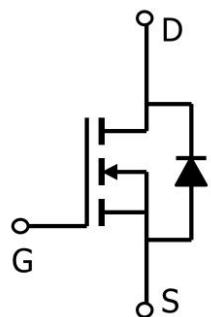
Application

- Power Management Functions
- DC-DC Converters

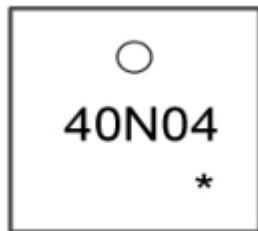
Package



Circuit diagram



Marking



40N04 =Device Code
* =Month Code

Absolute maximum ratings

($T_a=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	40	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current-Continuous	I_D	75	A
Pulsed Drain Current	I_{DM}	300	A
Maximum Power Dissipation	P_D	85	W
Single Pulse Avalanche Energy($L=0.1\text{mH}$)	E_{AS}	80	mJ
Thermal Resistance,Junction-to-Case ¹	$R_{\theta JC}$	1.47	$^\circ\text{C}/\text{W}$
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150	$^\circ\text{C}$



ZL MOSFET

ZL40N04D

Electrical characteristics

(T_A=25°C, unless otherwise noted)

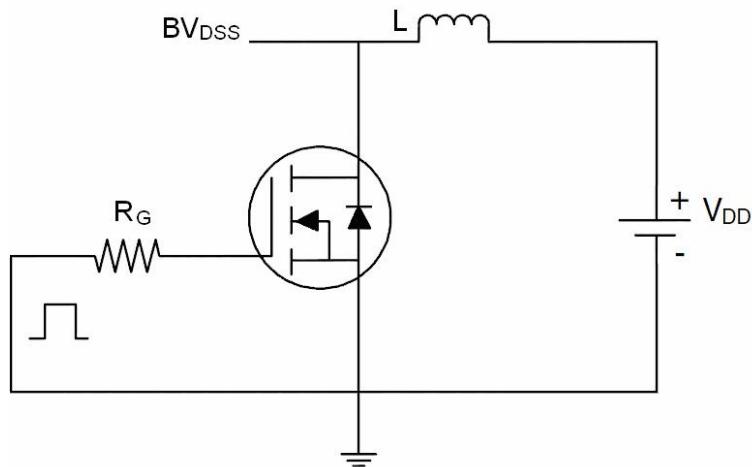
Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	BV (BR)DSS	V _{GS} = 0V, I _D = 250μA	40	45		V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 40V, V _{GS} = 0V			1	uA
Gate-Body Leakage Current	I _{GSS}	V _{GS} = ±20V, V _{DS} = 0V			±100	uA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	1.2	1.6	2.5	V
Drain-Source On-State Resistance ³	R _{DS(on)}	V _{GS} = 10V, I _D = 10A		4.5	6	mΩ
		V _{GS} = 4.5V, I _D = 6A		6.5	10	
Dynamic Characteristics						
Input Capacitance	C _{iss}	V _{DS} = 20V, V _{GS} = 0V, f = 1MHz			5000	pF
Output Capacitance	C _{oss}				900	
Reverse Transfer Capacitance	C _{rss}				500	
Total Gate Charge	Q _g	V _{DS} = 20V, I _D = 20A, V _{GS} = 10V		61		pF
Gate-Source Charge	Q _{gs}			15.3		
Gate-Drain Charge	Q _{gd}			14.5		
Switching Characteristics						
Turn-On Delay Time	T _{d(on)}	V _{DD} = 20V, R _L = 1Ω, V _{GS} = 10V, R _G = 3Ω		12		nS
Rise Time	T _r			11		
Turn-Off Delay Time	T _{d(off)}			39		
Fall Time	T _f			12		
Diode Characteristics						
Diode Forward Voltage	V _{SD}	V _{GS} = 0V, I _S = 1A			1.0	V

Note:

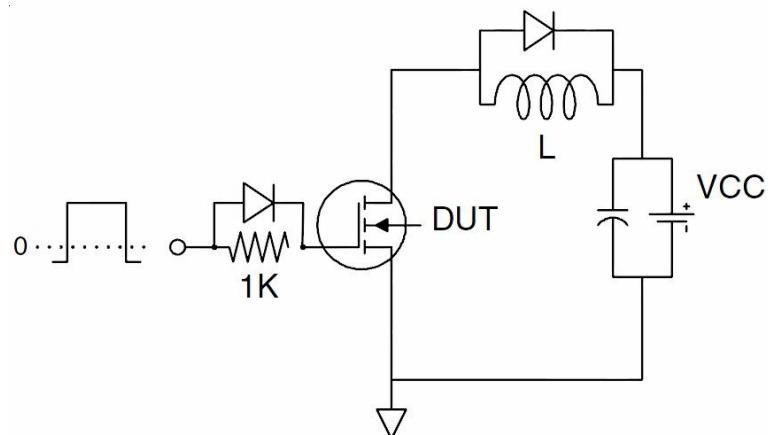
1. Surface Mounted on FR4 Board, t ≤ 10 sec.

Test Circuits

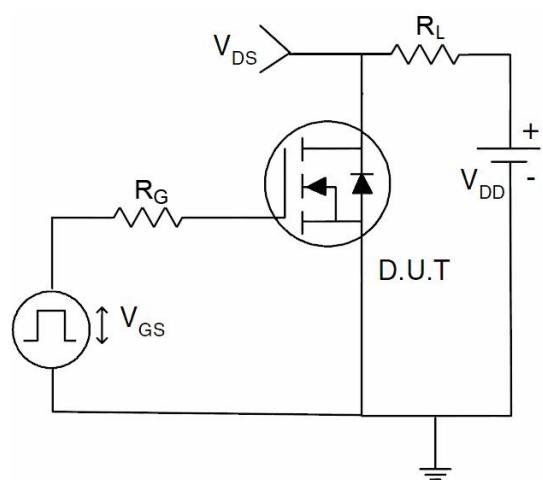
- EAS Test Circuits



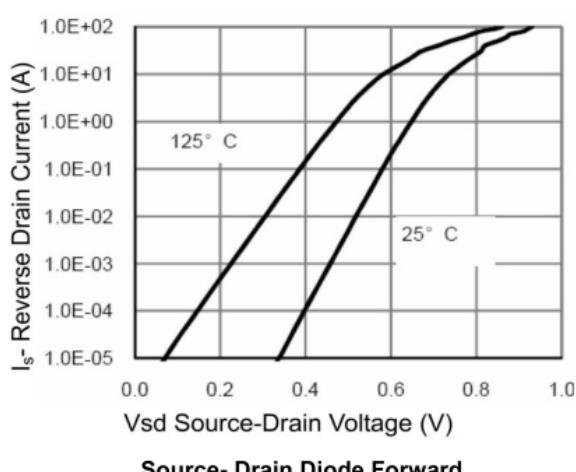
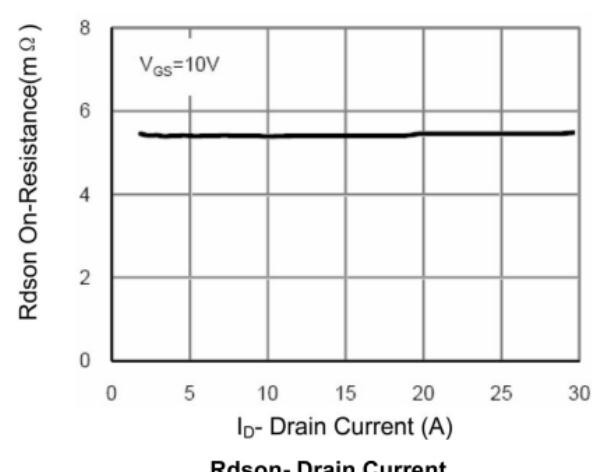
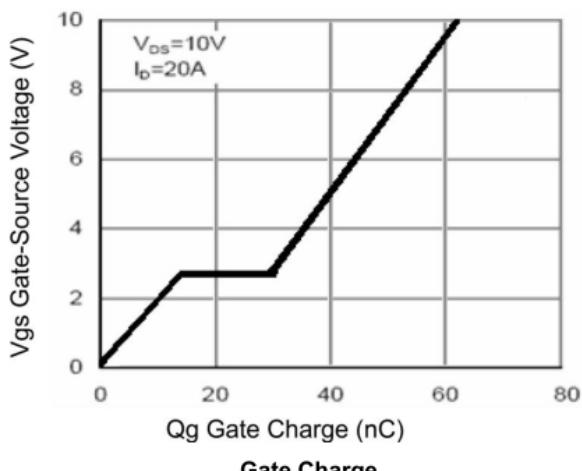
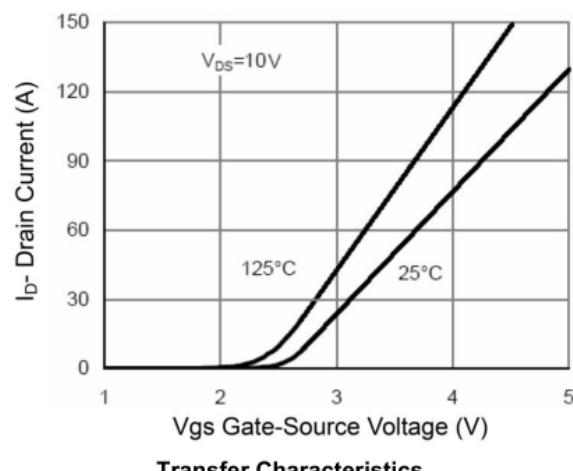
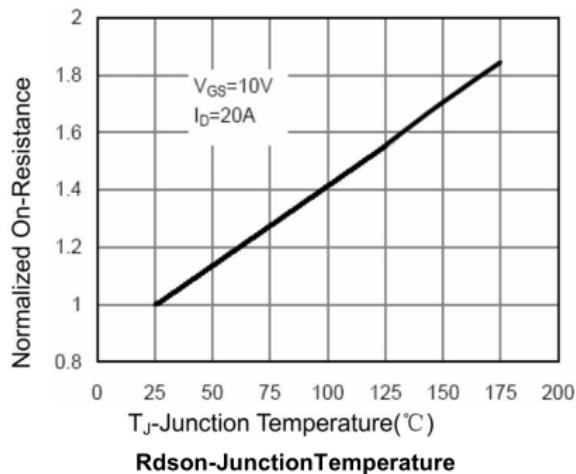
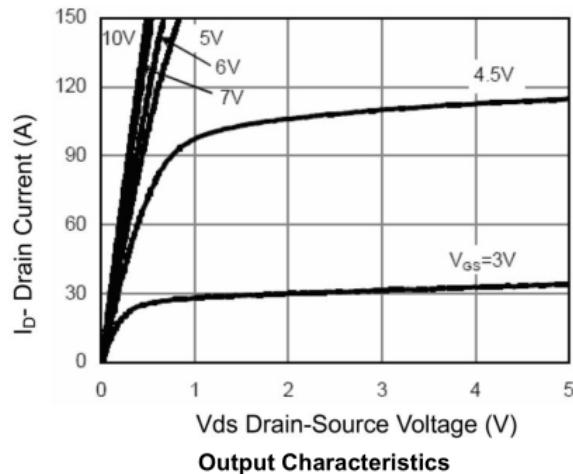
- Gate Charge Test Circuit



- Switch Time Test Circuit



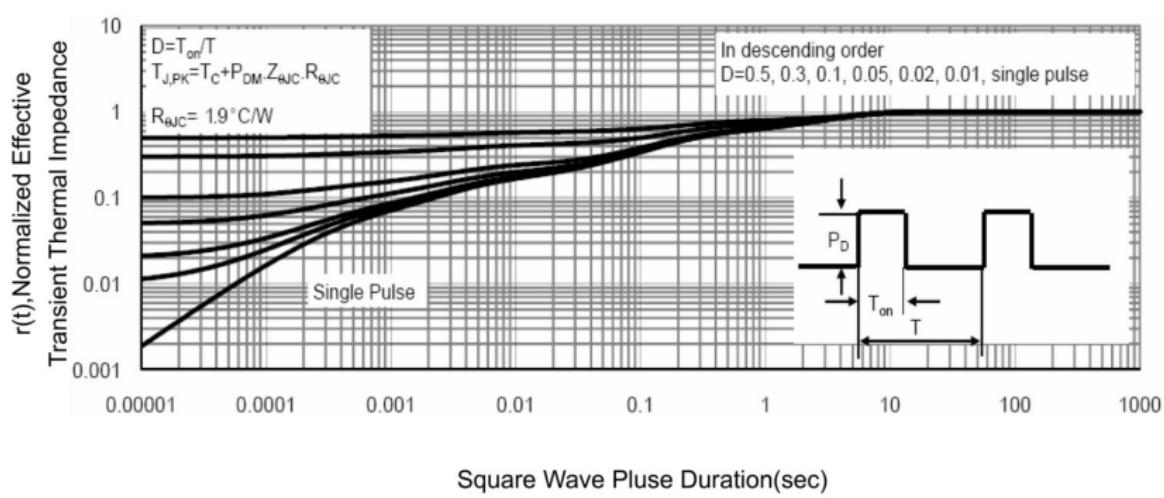
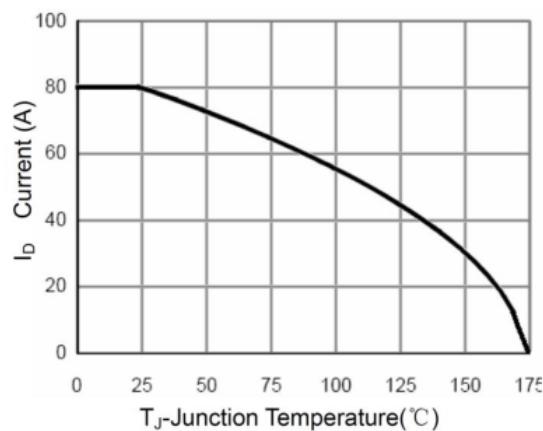
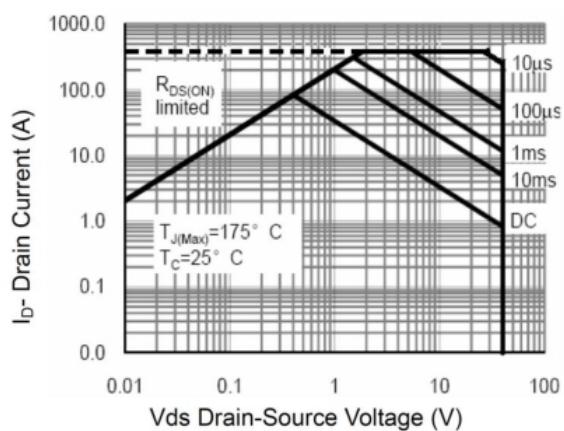
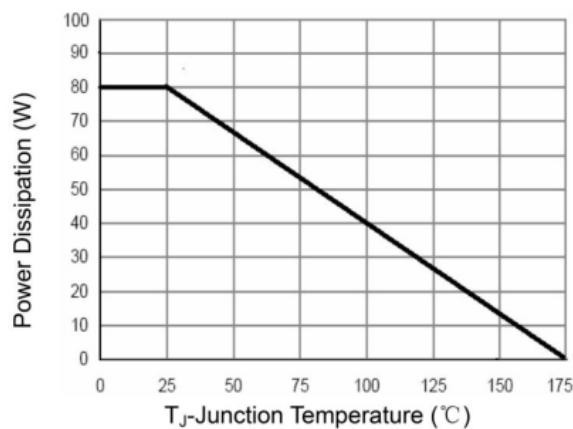
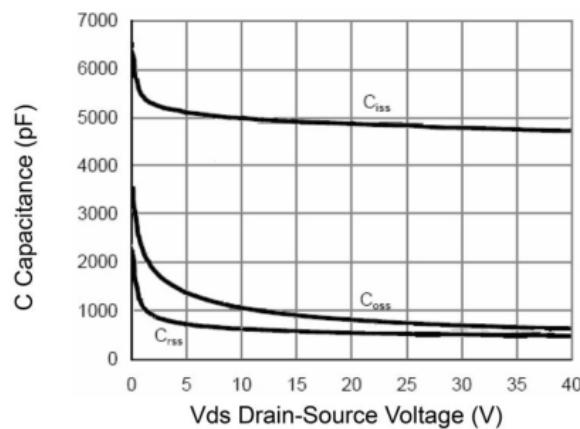
Typical Characteristics



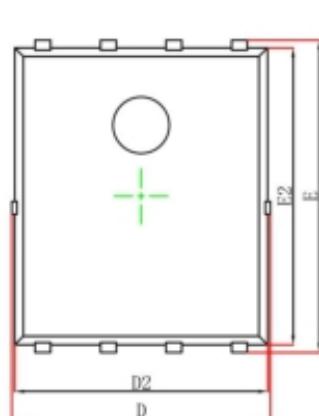


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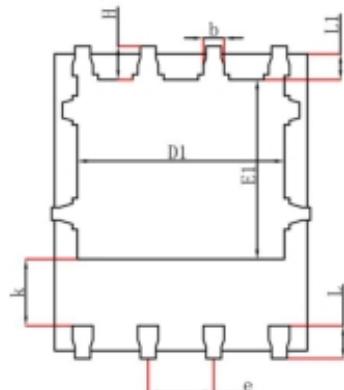
ZL40N04D

Normalizing factor: $r(t) = \frac{R_{BJC}}{P_D} \cdot \frac{T_{on}}{T} \cdot \ln\left(\frac{T}{T_{on}}\right)$ Normalized Maximum Transient Thermal Impedance: $\frac{r(t)}{r(0.01)}$

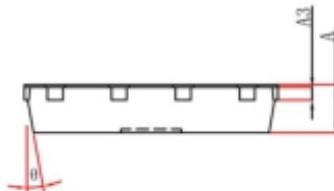
PDFNWB5X6-8L Package Information



Top View
[顶视图]



Bottom View
[背视图]



Side View
[侧视图]

Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.000	0.035	0.039
A3	0.254REF.			0.010REF.
D	4.944	5.096	0.195	0.201
E	5.974	6.126	0.235	0.241
D1	3.910	4.110	0.154	0.162
E1	3.375	3.575	0.133	0.141
D2	4.824	4.976	0.190	0.196
E2	5.674	5.826	0.223	0.229
k	1.190	1.390	0.047	0.055
b	0.350	0.450	0.014	0.018
e	1.270TYP.		0.050TYP.	
L	0.559	0.711	0.022	0.028
L1	0.424	0.576	0.017	0.023
H	0.574	0.726	0.023	0.029
θ	10°	12°	10°	12°